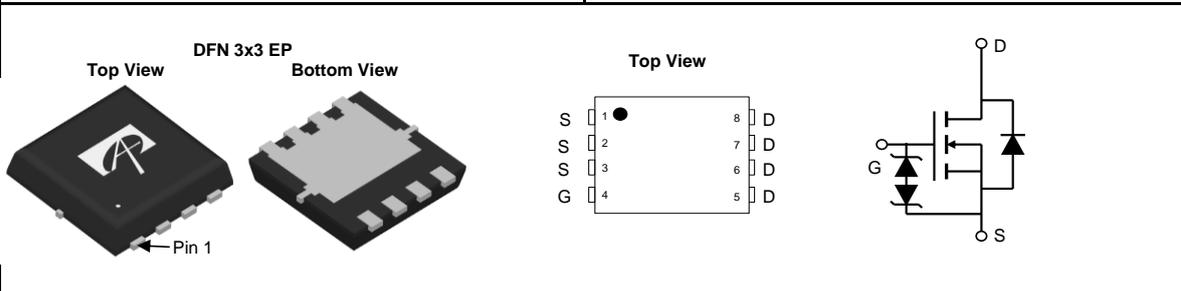


| General Description  | Product Summary  |                 |     |  |     |   |       |   |         |
|--|--|-----------------|-----|--|-----|---|-------|---|---------|
| <ul style="list-style-type: none"> <li>• Latest Trench Power AlphaMOS (αMOS LV) technology</li> <li>• Very Low RDS(on) at 4.5V<sub>GS</sub></li> <li>• Low Gate Charge</li> <li>• ESD protection</li> <li>• RoHS and Halogen-Free Compliant</li> </ul> | <table> <tr> <td>V<sub>DS</sub></td> <td>30V</td> </tr> <tr> <td>I<sub>D</sub> (at V<sub>GS</sub>=10V)</td> <td>34A</td> </tr> <tr> <td>R<sub>DS(ON)</sub> (at V<sub>GS</sub>=10V)</td> <td>&lt; 4mΩ</td> </tr> <tr> <td>R<sub>DS(ON)</sub> (at V<sub>GS</sub> = 4.5V)</td> <td>&lt; 6.8mΩ</td> </tr> </table> | V <sub>DS</sub> | 30V | I <sub>D</sub> (at V <sub>GS</sub> =10V) | 34A | R <sub>DS(ON)</sub> (at V <sub>GS</sub> =10V) | < 4mΩ | R <sub>DS(ON)</sub> (at V <sub>GS</sub> = 4.5V) | < 6.8mΩ |
| V <sub>DS</sub>  | 30V  |                 |     |  |     |   |       |   |         |
| I <sub>D</sub> (at V <sub>GS</sub> =10V)   | 34A  |                 |     |  |     |   |       |   |         |
| R <sub>DS(ON)</sub> (at V <sub>GS</sub> =10V)  | < 4mΩ  |                 |     |  |     |   |       |   |         |
| R <sub>DS(ON)</sub> (at V <sub>GS</sub> = 4.5V)  | < 6.8mΩ  |                 |     |  |     |   |       |   |         |
| <p><b>Application</b></p> <ul style="list-style-type: none"> <li>• DC/DC Converters</li> </ul>   | <p><b>Typical ESD protection</b></p> <p>100% UIS Tested<br/>100% R<sub>g</sub> Tested</p> <p><b>HBM Class 2</b></p>   |                 |     |  |     |   |       |   |         |



**Absolute Maximum Ratings** T<sub>A</sub>=25°C unless otherwise noted

| Parameter                              | Symbol                            | Maximum               | Units |
|--|-----------------------------------|-----------------------|-------|
| Drain-Source Voltage                   | V <sub>DS</sub>                   | 30                    | V     |
| Gate-Source Voltage                    | V <sub>GS</sub>                   | ±20                   | V     |
| Continuous Drain Current <sup>G</sup>  | I <sub>D</sub>                    | T <sub>C</sub> =25°C  | 34    |
|  |                                   | T <sub>C</sub> =100°C | 27    |
| Pulsed Drain Current <sup>C</sup>      | I <sub>DM</sub>                   | 136                   | A     |
| Continuous Drain Current               | I <sub>DSM</sub>                  | T <sub>A</sub> =25°C  | 21    |
|  |                                   | T <sub>A</sub> =70°C  | 17    |
| Avalanche Current <sup>C</sup>         | I <sub>AS</sub>                   | 35                    | A     |
| Avalanche energy L=0.05mH <sup>C</sup> | E <sub>AS</sub>                   | 31                    | mJ    |
| V <sub>DS</sub> Spike                  | V <sub>SPIKE</sub>                | 36                    | V     |
| Power Dissipation <sup>B</sup>         | P <sub>D</sub>                    | T <sub>C</sub> =25°C  | 31    |
|  |                                   | T <sub>C</sub> =100°C | 12    |
| Power Dissipation <sup>A</sup>         | P <sub>DSM</sub>                  | T <sub>A</sub> =25°C  | 3.1   |
|  |                                   | T <sub>A</sub> =70°C  | 2     |
| Junction and Storage Temperature Range | T <sub>J</sub> , T <sub>STG</sub> | -55 to 150            | °C    |

**Thermal Characteristics**

| Parameter                                  | Symbol           | Typ | Max | Units |
|--|------------------|-----|-----|-------|
| Maximum Junction-to-Ambient <sup>A</sup>   | R <sub>θJA</sub> | 30  | 40  | °C/W  |
| Maximum Junction-to-Ambient <sup>A D</sup> |                  | 60  | 75  | °C/W  |
| Maximum Junction-to-Case                   | R <sub>θJC</sub> | 3.2 | 4   | °C/W  |

**Electrical Characteristics (T<sub>J</sub>=25°C unless otherwise noted)**

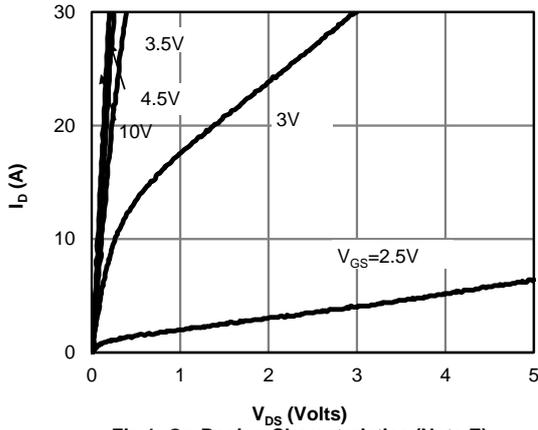
| Symbol                      | Parameter  | Conditions   | Min | Typ  | Max    | Units |
|-----------------------------|--|--|-----|------|--------|-------|
| <b>STATIC PARAMETERS</b>    |  |  |     |      |        |       |
| BV <sub>DSS</sub>           | Drain-Source Breakdown Voltage                     | I <sub>D</sub> =250μA, V <sub>GS</sub> =0V   | 30  |      |        | V     |
| I <sub>DSS</sub>            | Zero Gate Voltage Drain Current                    | V <sub>DS</sub> =30V, V <sub>GS</sub> =0V<br>T <sub>J</sub> =55°C                          |     |      | 1<br>5 | μA    |
| I <sub>GSS</sub>            | Gate-Body leakage current                          | V <sub>DS</sub> =0V, V <sub>GS</sub> = ±20V  |     |      | ±10    | μA    |
| V <sub>GS(th)</sub>         | Gate Threshold Voltage                             | V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> =250μA                                   | 1.2 | 1.8  | 2.2    | V     |
| R <sub>DS(ON)</sub>         | Static Drain-Source On-Resistance                  | V <sub>GS</sub> =10V, I <sub>D</sub> =20A<br>T <sub>J</sub> =125°C                         |     | 3.2  | 4      | mΩ    |
|                             |  | V <sub>GS</sub> =4.5V, I <sub>D</sub> =16A   |     | 5    | 6.2    | mΩ    |
| g <sub>FS</sub>             | Forward Transconductance                           | V <sub>DS</sub> =5V, I <sub>D</sub> =20A   |     | 62   |        | S     |
| V <sub>SD</sub>             | Diode Forward Voltage                              | I <sub>S</sub> =1A, V <sub>GS</sub> =0V  |     | 0.7  | 1      | V     |
| I <sub>S</sub>              | Maximum Body-Diode Continuous Current <sup>G</sup> |  |     |      | 34     | A     |
| <b>DYNAMIC PARAMETERS</b>   |  |  |     |      |        |       |
| C <sub>iss</sub>            | Input Capacitance                                  | V <sub>GS</sub> =0V, V <sub>DS</sub> =15V, f=1MHz  |     | 1540 |        | pF    |
| C <sub>oss</sub>            | Output Capacitance                                 |  |     | 485  |        | pF    |
| C <sub>rss</sub>            | Reverse Transfer Capacitance                       |  |     | 448  |        | pF    |
| R <sub>g</sub>              | Gate resistance                                    | V <sub>GS</sub> =0V, V <sub>DS</sub> =0V, f=1MHz   | 0.8 | 1.7  | 2.6    | Ω     |
| <b>SWITCHING PARAMETERS</b> |  |  |     |      |        |       |
| Q <sub>g</sub> (10V)        | Total Gate Charge                                  | V <sub>GS</sub> =10V, V <sub>DS</sub> =15V, I <sub>D</sub> =20A                            |     | 33.4 | 45     | nC    |
| Q <sub>g</sub> (4.5V)       | Total Gate Charge                                  |  |     | 19.7 | 27     | nC    |
| Q <sub>gs</sub>             | Gate Source Charge                                 |  |     | 3.3  |        | nC    |
| Q <sub>gd</sub>             | Gate Drain Charge                                  |  |     | 15.0 |        | nC    |
| t <sub>D(on)</sub>          | Turn-On DelayTime                                  | V <sub>GS</sub> =10V, V <sub>DS</sub> =15V, R <sub>L</sub> =0.75Ω,<br>R <sub>GEN</sub> =3Ω |     | 7    |        | ns    |
| t <sub>r</sub>              | Turn-On Rise Time                                  |  |     | 8.3  |        | ns    |
| t <sub>D(off)</sub>         | Turn-Off DelayTime                                 |  |     | 24   |        | ns    |
| t <sub>f</sub>              | Turn-Off Fall Time                                 |  |     | 10   |        | ns    |
| t <sub>rr</sub>             | Body Diode Reverse Recovery Time                   | I <sub>F</sub> =20A, di/dt=500A/μs   |     | 15.2 |        | ns    |
| Q <sub>rr</sub>             | Body Diode Reverse Recovery Charge                 | I <sub>F</sub> =20A, di/dt=500A/μs   |     | 22.2 |        | nC    |

- A. The value of R<sub>θJA</sub> is measured with the device mounted on 1in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with T<sub>A</sub>=25° C. The Power dissipation P<sub>DSM</sub> is based on R<sub>θJA</sub> and the maximum allowed junction temperature of 150° C. The value in any given application depends on the user's specific board design.
- B. The power dissipation P<sub>D</sub> is based on T<sub>J(MAX)</sub>=150° C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.
- C. Repetitive rating, pulse width limited by junction temperature T<sub>J(MAX)</sub>=150° C. Ratings are based on low frequency and duty cycles to keep initial T<sub>J</sub>=25° C.
- D. The R<sub>θJA</sub> is the sum of the thermal impedance from junction to case R<sub>θJC</sub> and case to ambient.
- E. The static characteristics in Figures 1 to 6 are obtained using <300μs pulses, duty cycle 0.5% max.
- F. These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of T<sub>J(MAX)</sub>=150° C. The SOA curve provides a single pulse rating.
- G. The maximum current rating is package limited.
- H. These tests are performed with the device mounted on 1 in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with T<sub>A</sub>=25° C.

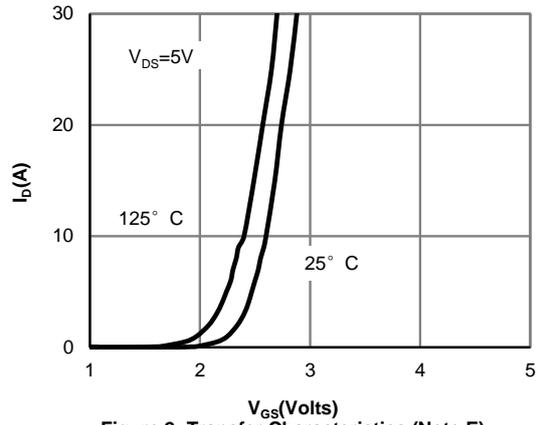
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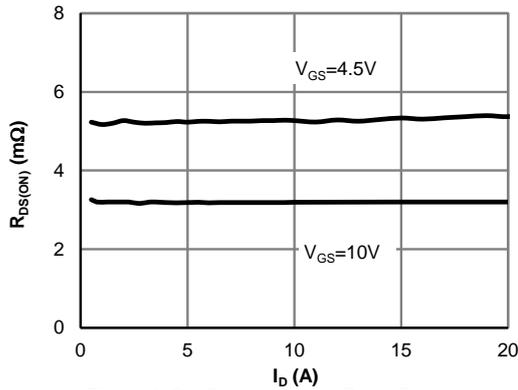
**TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS**



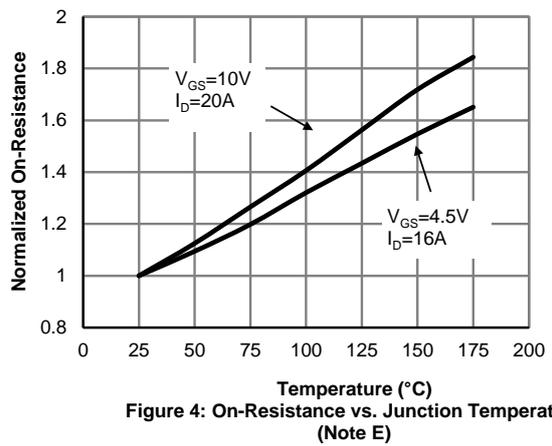
**Figure 1: On-Region Characteristics (Note E)**



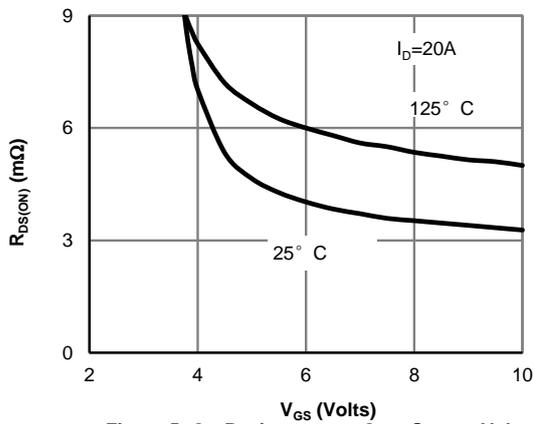
**Figure 2: Transfer Characteristics (Note E)**



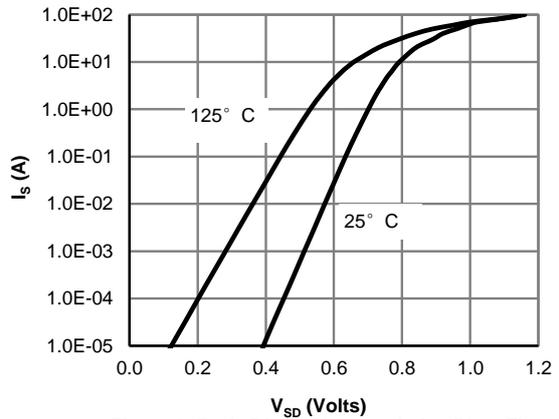
**Figure 3: On-Resistance vs. Drain Current and Gate Voltage (Note E)**



**Figure 4: On-Resistance vs. Junction Temperature (Note E)**

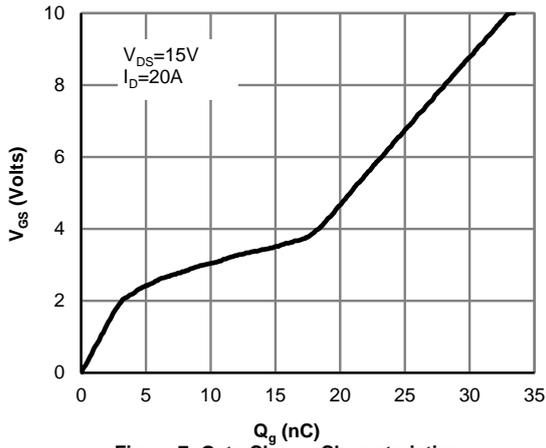


**Figure 5: On-Resistance vs. Gate-Source Voltage (Note E)**

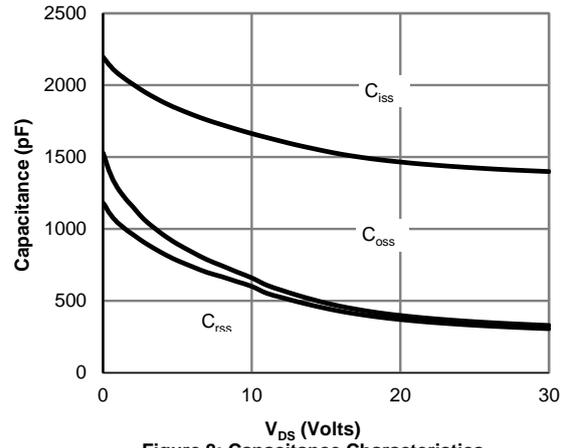


**Figure 6: Body-Diode Characteristics (Note E)**

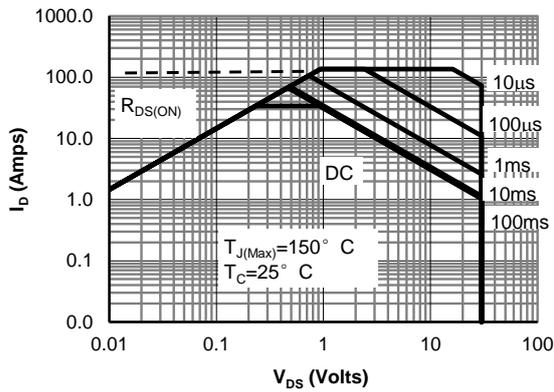
**TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS**



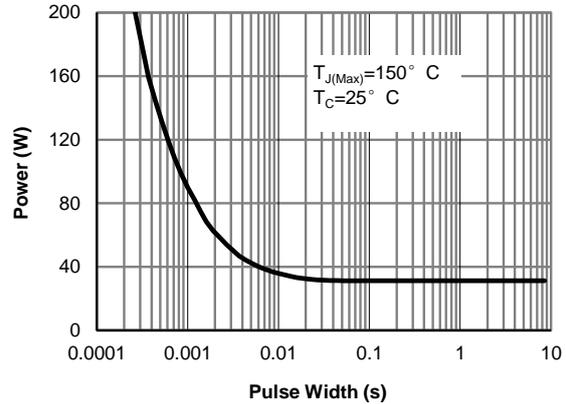
**Figure 7: Gate-Charge Characteristics**



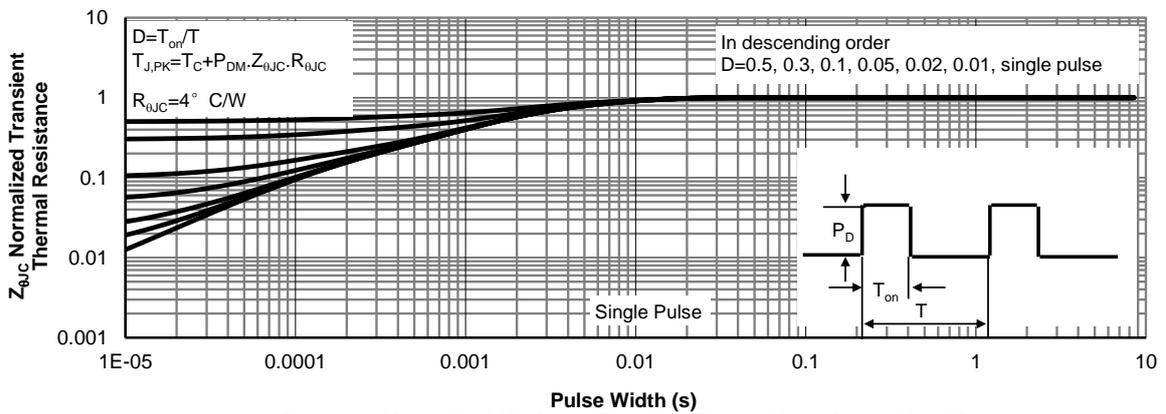
**Figure 8: Capacitance Characteristics**



**Figure 9: Maximum Forward Biased Safe Operating Area (Note F)**



**Figure 10: Single Pulse Power Rating Junction-to-Case (Note F)**



**Figure 11: Normalized Maximum Transient Thermal Impedance (Note F)**

**TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS**

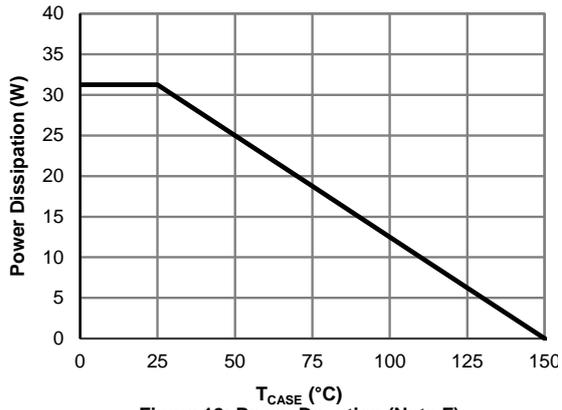


Figure 12: Power De-rating (Note F)

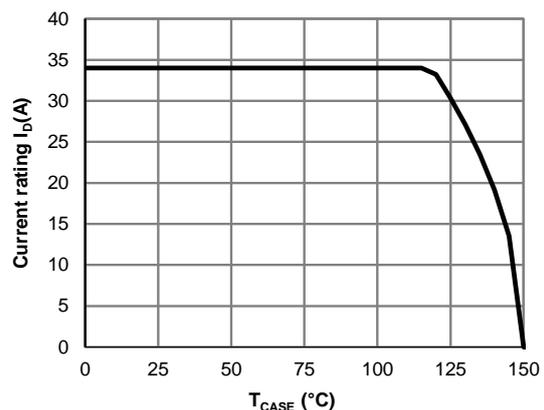


Figure 13: Current De-rating (Note F)

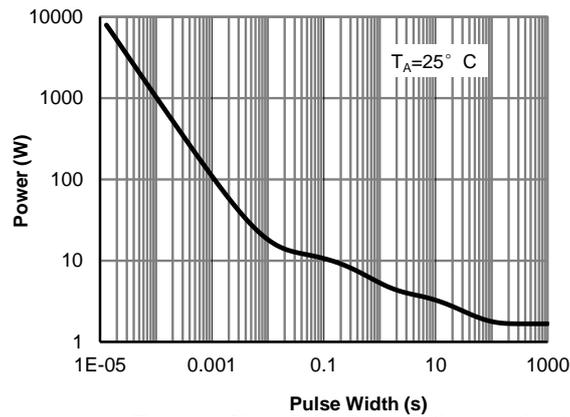


Figure 14: Single Pulse Power Rating Junction-to-Ambient (Note H)

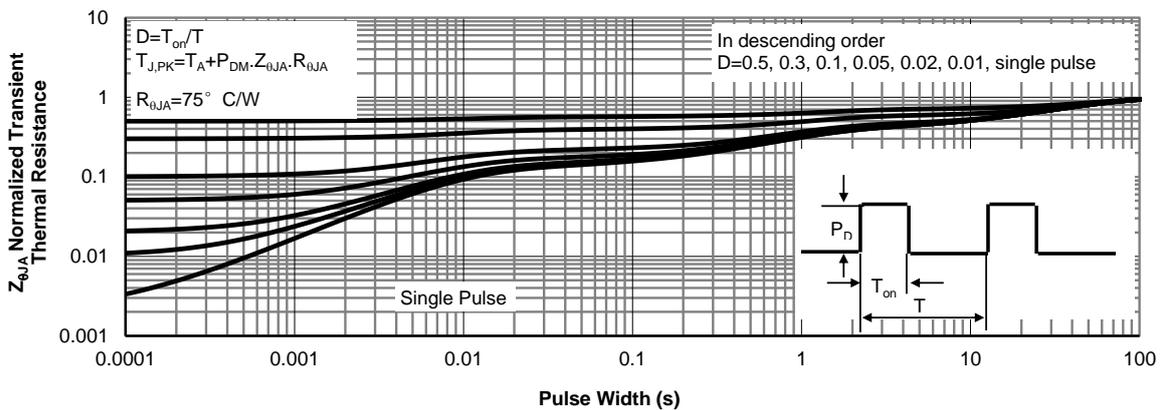
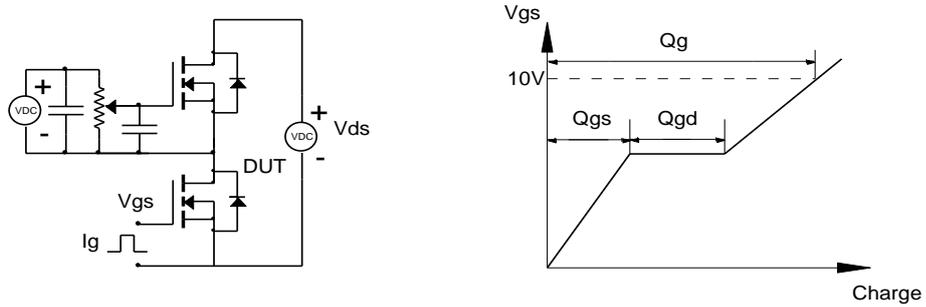
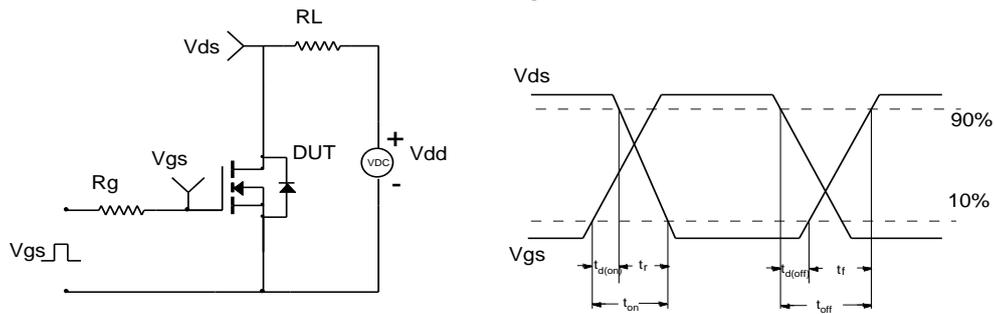


Figure 15: Normalized Maximum Transient Thermal Impedance (Note H)

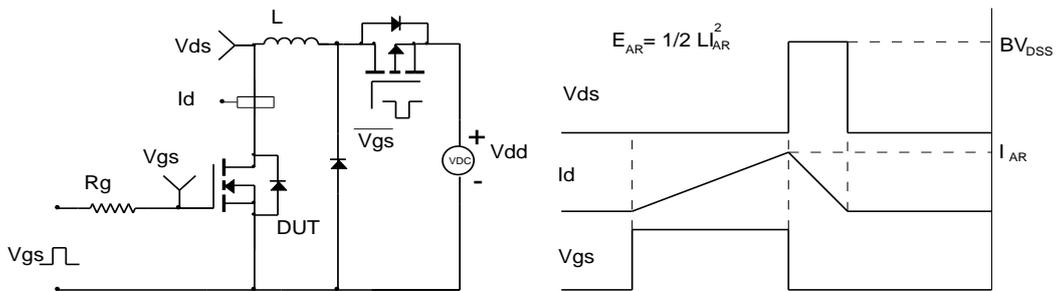
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